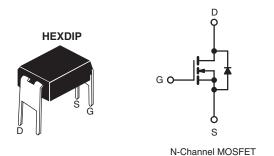


Vishay Siliconix

COMPLIANT

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	60				
$R_{DS(on)}\left(\Omega\right)$	$V_{GS} = 5.0 \text{ V}$	0.10			
Q _g (Max.) (nC)	18				
Q _{gs} (nC)	4.5				
Q _{gd} (nC)	12				
Configuration	Single				



FEATURES

- Dynamic dV/dt Rating
- · For Automatic Insertion
- End Stackable
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- 175 °C Operating Temperature
- · Fast Switching
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertiable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain servers as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION			
Package	HEXDIP		
Lead (Pb)-free	IRLD024PbF		
	SiHLD024-E3		
SnPb	IRLD024		
	SiHLD024		

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60		
Gate-Source Voltage			V_{GS}	± 10	V	
Continuous Drain Current	V _{GS} at 5.0 V	T _C = 25 °C	- I _D	2.5	А	
	VGS at 5.0 V	T _C = 100 °C		1.8		
Pulsed Drain Current ^a	sed Drain Current ^a			20		
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	91	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	1.3	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 16 mH, R_G = 25 Ω , I_{AS} = 2.5 A (see fig. 12).
- c. $I_{SD} \leq$ 17 A, $dI/dt \leq$ 140 A/ μ s, $V_{DD} \leq$ V_{DS} , $T_{J} \leq$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRLD024, SiHLD024

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R_{thJA}	-	120	°C/W	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static		_					
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	60	_	-	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	Reference	Reference to 25 °C, I _D = 1 mA		0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		-	2.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 10 V		-	± 100	nA
7 0 1 1/1 5 1 0 1		V _{DS} = 60 V, V _{GS} = 0 V		-	-	25	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V,	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
		V _{GS} = 5.0 V	I _D = 1.5A ^b	-	-	0.10	Ω
Drain-Source On-State Resistance	$R_{DS(on)}$	V _{GS} = 4.0 V	I _D = 1.3 A ^b	-	-	0.14	
Forward Transconductance	9 _{fs}	V _{DS} = 25 V, I _D = 1.5 A ^b		3.7	-	-	S
Dynamic						<u>'</u>	
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V}$ $V_{DS} = 25 \text{ V}$ f = 1.0 MHz, see fig. 5		-	870	-	pF
Output Capacitance	C _{oss}			-	360	-	
Reverse Transfer Capacitance	C _{rss}			-	53	-	
Total Gate Charge	Qg			-	-	18	
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$V_{GS} = 5.0 \text{ V}$ $I_D = 17 \text{ A}, V_{DS} = 48 \text{ V}$ see fig. 6 and 13 ^b		-	4.5	nC
Gate-Drain Charge	Q _{gd}		occ lig. c and re	-	-	12	1
Turn-On Delay Time	t _{d(on)}			-	11	-	
Rise Time	t _r	Von	V _{DD} = 30 V, I _D = 17 A		110	-	- ns
Turn-Off Delay Time	t _{d(off)}	$R_G = 9.0 \Omega$, $R_D = 1.7 \Omega$, see fig. 10^b		-	23	-	
Fall Time	t _f			-	41	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	- nH
Internal Source Inductance	L _S			-	6.0	-	
Drain-Source Body Diode Characteristic	s	1		•			
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.5	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	20	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 2.5 A, V _{GS} = 0 V ^b		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 17 A, dl/dt = 100 A/μs ^b		-	110	260	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.49	1.5	μС
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D				 L _D)	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

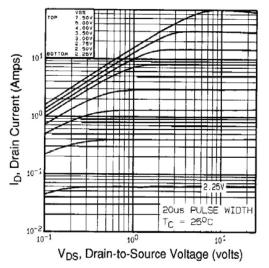


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

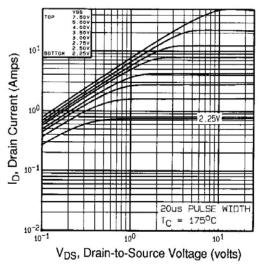


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

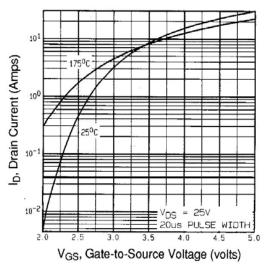


Fig. 3 - Typical Transfer Characteristics

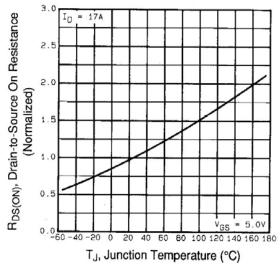


Fig. 4 - Normalized On-Resistance vs. Temperature

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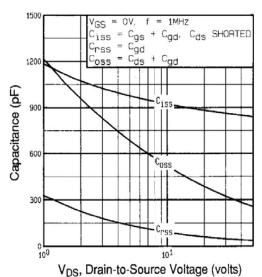


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

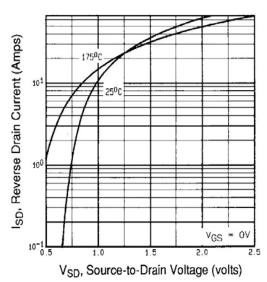


Fig. 7 - Typical Source-Drain Diode Forward Voltage

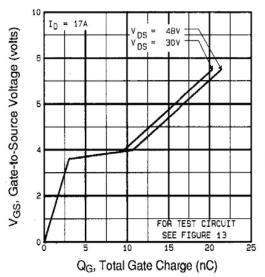


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

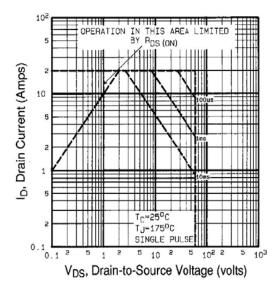


Fig. 8 - Maximum Safe Operating Area





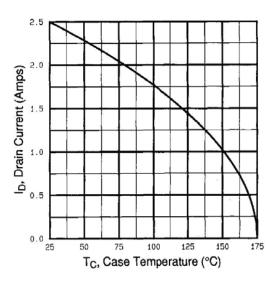


Fig. 9 - Maximum Drain Current vs. Case Temperature

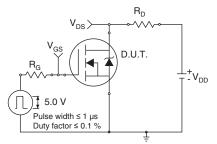


Fig. 10a - Switching Time Test Circuit

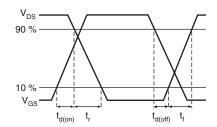


Fig. 10b - Switching Time Waveforms

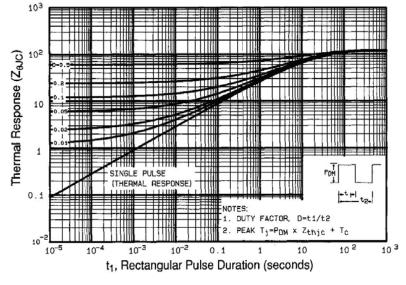


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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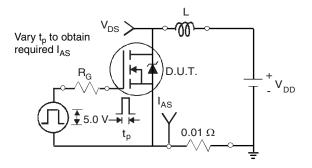


Fig. 12a - Unclamped Inductive Test Circuit

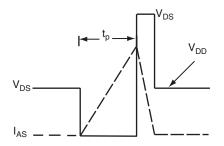


Fig. 12b - Unclamped Inductive Waveforms

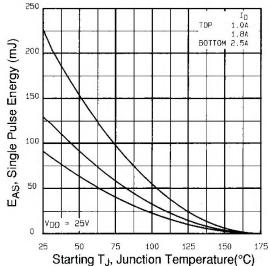


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

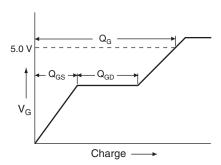


Fig. 13a - Basic Gate Charge Waveform

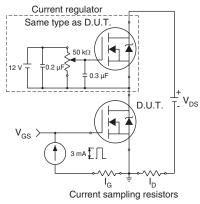
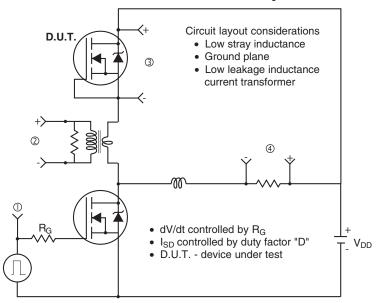
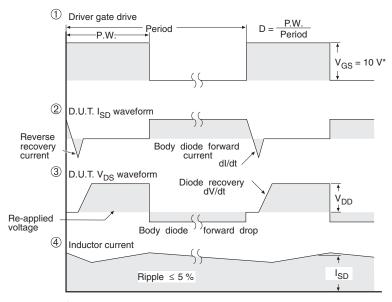


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com